

# IRF7902PbF

HEXFET® Power MOSFET

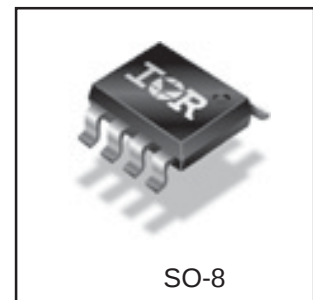
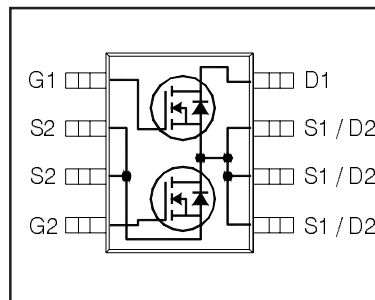
## Applications

- Dual SO-8 MOSFET for POL Converters in Notebook Computers, Servers, Graphics Cards, Game Consoles and Set-Top Box

## Benefits

- Very Low  $R_{DS(on)}$  at 4.5V  $V_{GS}$
- Low Gate Charge
- Fully Characterized Avalanche Voltage and Current
- 20V  $V_{GS}$  Max. Gate Rating
- Improved Body Diode Reverse Recovery
- Lead-Free

| $V_{DSS}$ | $R_{DS(on)}$ max          | $I_D$ |
|-----------|---------------------------|-------|
| 30V       | Q1 22.6mΩ@ $V_{GS} = 10V$ | 6.4A  |
|           | Q2 14.4mΩ@ $V_{GS} = 10V$ | 9.7A  |



SO-8

## Absolute Maximum Ratings

|                          | Parameter                                | Q1 Max.      | Q2 Max. | Units |
|--------------------------|------------------------------------------|--------------|---------|-------|
| $V_{DS}$                 | Drain-to-Source Voltage                  | 30           |         | V     |
| $V_{GS}$                 | Gate-to-Source Voltage                   | $\pm 20$     |         |       |
| $I_D @ T_A = 25^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V$ | 6.4          | 9.7     | A     |
| $I_D @ T_A = 70^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V$ | 5.1          | 7.8     |       |
| $I_{DM}$                 | Pulsed Drain Current ①                   | 51           | 78      |       |
| $P_D @ T_A = 25^\circ C$ | Power Dissipation                        | 1.4          | 2.0     | W     |
| $P_D @ T_A = 70^\circ C$ | Power Dissipation                        | 0.9          | 1.3     |       |
|                          | Linear Derating Factor                   | 0.011        | 0.016   | W/°C  |
| $T_J$                    | Operating Junction and                   | -55 to + 150 |         | °C    |
| $T_{STG}$                | Storage Temperature Range                |              |         |       |

## Thermal Resistance

|                 | Parameter                | Q1 Max. | Q2 Max. | Units |
|-----------------|--------------------------|---------|---------|-------|
| $R_{\theta JL}$ | Junction-to-Drain Lead ⑤ | 20      | 20      | °C/W  |
| $R_{\theta JA}$ | Junction-to-Ambient ④ ⑤  | 90      | 62.5    |       |

Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

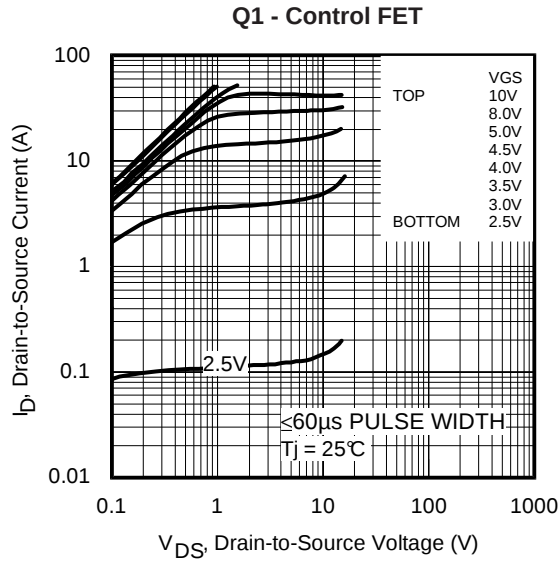
|                                       | Parameter                                           |       | Min. | Typ.  | Max. | Units | Conditions                                                                                             |
|---------------------------------------|-----------------------------------------------------|-------|------|-------|------|-------|--------------------------------------------------------------------------------------------------------|
| BV <sub>DSS</sub>                     | Drain-to-Source Breakdown Voltage                   | Q1&Q2 | 30   | —     | —    | V     | V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA                                                           |
| ΔBV <sub>DSS</sub> /ΔT <sub>J</sub>   | Breakdown Voltage Temp. Coefficient                 | Q1    | —    | 0.023 | —    | V/°C  | Reference to 25°C, I <sub>D</sub> = 1mA                                                                |
|                                       |                                                     | Q2    | —    | 0.025 | —    |       |                                                                                                        |
| R <sub>DS(on)</sub>                   | Static Drain-to-Source On-Resistance                | Q1    | —    | 18.1  | 22.6 | mΩ    | V <sub>GS</sub> = 10V, I <sub>D</sub> = 6.4A ③                                                         |
|                                       |                                                     |       | —    | 23.8  | 29.7 |       | V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 5.1A ③                                                        |
|                                       |                                                     | Q2    | —    | 11.5  | 14.4 |       | V <sub>GS</sub> = 10V, I <sub>D</sub> = 9.7A ③                                                         |
|                                       |                                                     |       | —    | 14.9  | 18.7 |       | V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 7.8A ③                                                        |
| V <sub>GS(th)</sub>                   | Gate Threshold Voltage                              | Q1&Q2 | 1.35 | 1.8   | 2.25 | V     | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 25μA                                              |
| ΔV <sub>GS(th)</sub> /ΔT <sub>J</sub> | Gate Threshold Voltage Coefficient                  | Q1    | —    | -4.7  | —    | mV/°C |                                                                                                        |
|                                       |                                                     | Q2    | —    | -5.9  | —    |       |                                                                                                        |
| I <sub>DSS</sub>                      | Drain-to-Source Leakage Current                     | Q1&Q2 | —    | —     | 1.0  | μA    | V <sub>DS</sub> = 24V, V <sub>GS</sub> = 0V                                                            |
|                                       |                                                     | Q1&Q2 | —    | —     | 150  |       | V <sub>DS</sub> = 24V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 125°C                                    |
| I <sub>GSS</sub>                      | Gate-to-Source Forward Leakage                      | Q1&Q2 | —    | —     | 100  | nA    | V <sub>GS</sub> = 20V                                                                                  |
|                                       | Gate-to-Source Reverse Leakage                      | Q1&Q2 | —    | —     | -100 |       | V <sub>GS</sub> = -20V                                                                                 |
| g <sub>fs</sub>                       | Forward Transconductance                            | Q1    | 13   | —     | —    | S     | V <sub>DS</sub> = 15V, I <sub>D</sub> = 5.1A                                                           |
|                                       |                                                     | Q2    | 19   | —     | —    |       | V <sub>DS</sub> = 15V, I <sub>D</sub> = 7.8A                                                           |
| Q <sub>g</sub>                        | Total Gate Charge                                   | Q1    | —    | 4.6   | 6.9  | nC    | Q1<br>V <sub>DS</sub> = 15V<br>V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 5.1A                           |
|                                       |                                                     | Q2    | —    | 6.5   | 9.8  |       |                                                                                                        |
| Q <sub>gs1</sub>                      | Pre-V <sub>th</sub> Gate-to-Source Charge           | Q1    | —    | 0.9   | —    |       |                                                                                                        |
|                                       |                                                     | Q2    | —    | 1.4   | —    |       |                                                                                                        |
| Q <sub>gs2</sub>                      | Post-V <sub>th</sub> Gate-to-Source Charge          | Q1    | —    | 0.5   | —    |       | Q2<br>V <sub>DS</sub> = 15V<br>V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 7.8A                           |
|                                       |                                                     | Q2    | —    | 0.8   | —    |       |                                                                                                        |
| Q <sub>gd</sub>                       | Gate-to-Drain Charge                                | Q1    | —    | 1.8   | —    |       |                                                                                                        |
|                                       |                                                     | Q2    | —    | 2.3   | —    |       |                                                                                                        |
| Q <sub>godr</sub>                     | Gate Charge Overdrive                               | Q1    | —    | 1.4   | —    |       |                                                                                                        |
|                                       |                                                     | Q2    | —    | 2.0   | —    |       |                                                                                                        |
| Q <sub>sw</sub>                       | Switch Charge (Q <sub>gs2</sub> + Q <sub>gd</sub> ) | Q1    | —    | 2.3   | —    |       |                                                                                                        |
|                                       |                                                     | Q2    | —    | 3.1   | —    |       |                                                                                                        |
| Q <sub>oss</sub>                      | Output Charge                                       | Q1    | —    | 3.0   | —    | nC    | V <sub>DS</sub> = 16V, V <sub>GS</sub> = 0V                                                            |
|                                       |                                                     | Q2    | —    | 4.4   | —    |       |                                                                                                        |
| R <sub>G</sub>                        | Gate Resistance                                     | Q1    | —    | 3.1   | 4.9  | Ω     | Q1<br>V <sub>DD</sub> = 15V, V <sub>GS</sub> = 4.5V<br>I <sub>D</sub> = 5.1A                           |
|                                       |                                                     | Q2    | —    | 3.1   | 4.9  |       |                                                                                                        |
| t <sub>d(on)</sub>                    | Turn-On Delay Time                                  | Q1    | —    | 7.4   | —    | ns    |                                                                                                        |
|                                       |                                                     | Q2    | —    | 6.1   | —    |       |                                                                                                        |
| t <sub>r</sub>                        | Rise Time                                           | Q1    | —    | 8.2   | —    |       |                                                                                                        |
|                                       |                                                     | Q2    | —    | 8.6   | —    |       |                                                                                                        |
| t <sub>d(off)</sub>                   | Turn-Off Delay Time                                 | Q1    | —    | 8.4   | —    |       | Q2<br>V <sub>DD</sub> = 15V, V <sub>GS</sub> = 4.5V<br>I <sub>D</sub> = 7.8A<br>Clamped Inductive Load |
|                                       |                                                     | Q2    | —    | 8.2   | —    |       |                                                                                                        |
| t <sub>f</sub>                        | Fall Time                                           | Q1    | —    | 3.4   | —    |       |                                                                                                        |
|                                       |                                                     | Q2    | —    | 3.3   | —    |       |                                                                                                        |
| C <sub>iss</sub>                      | Input Capacitance                                   | Q1    | —    | 580   | —    | pF    | V <sub>GS</sub> = 0V<br>V <sub>DS</sub> = 15V<br>f = 1.0MHz                                            |
|                                       |                                                     | Q2    | —    | 900   | —    |       |                                                                                                        |
| C <sub>oss</sub>                      | Output Capacitance                                  | Q1    | —    | 130   | —    |       |                                                                                                        |
|                                       |                                                     | Q2    | —    | 190   | —    |       |                                                                                                        |
| C <sub>rss</sub>                      | Reverse Transfer Capacitance                        | Q1    | —    | 74    | —    |       |                                                                                                        |
|                                       |                                                     | Q2    | —    | 86    | —    |       |                                                                                                        |

## Avalanche Characteristics

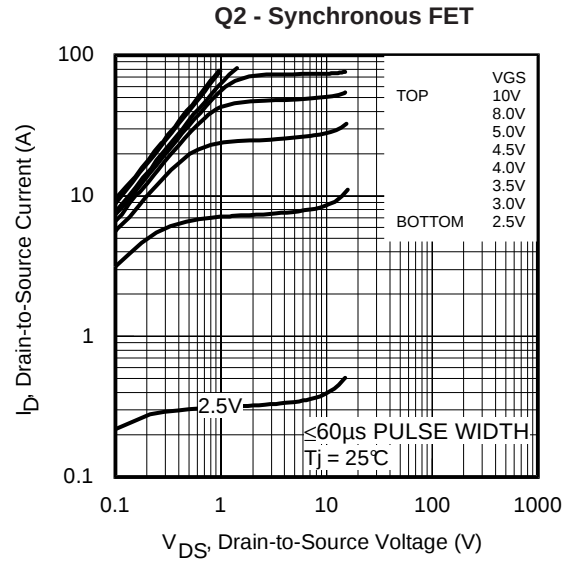
|                 | Parameter                       | Typ. | Q1 Max. | Q2 Max. | Units |
|-----------------|---------------------------------|------|---------|---------|-------|
| E <sub>AS</sub> | Single Pulse Avalanche Energy ② | —    | 3.4     | 7.3     | mJ    |
| I <sub>AR</sub> | Avalanche Current ①             | —    | 5.1     | 7.8     | A     |

## Diode Characteristics

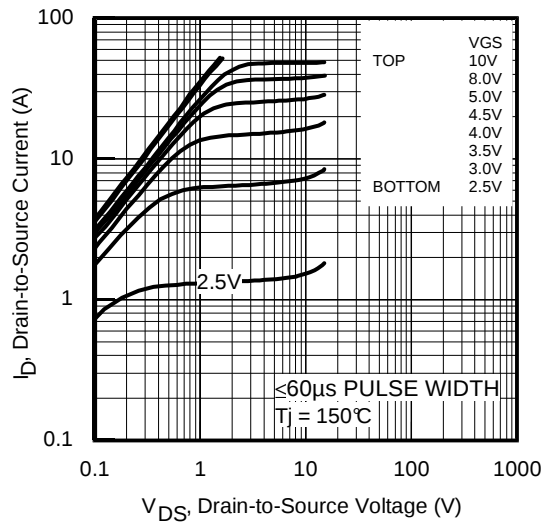
|                 | Parameter                              |    | Min. | Typ. | Max. | Units | Conditions                                                                                |
|-----------------|----------------------------------------|----|------|------|------|-------|-------------------------------------------------------------------------------------------|
| I <sub>S</sub>  | Continuous Source Current (Body Diode) | Q1 | —    | —    | 1.7  | A     | MOSFET symbol showing the integral reverse p-n junction diode.                            |
|                 |                                        | Q2 | —    | —    | 2.5  |       |                                                                                           |
| I <sub>SM</sub> | Pulsed Source Current (Body Diode) ①   | Q1 | —    | —    | 51   | A     | T <sub>J</sub> = 25°C, I <sub>S</sub> = 5.1A, V <sub>GS</sub> = 0V ③                      |
|                 |                                        | Q2 | —    | —    | 78   |       |                                                                                           |
| V <sub>SD</sub> | Diode Forward Voltage                  | Q1 | —    | —    | 1.0  | V     | T <sub>J</sub> = 25°C, I <sub>S</sub> = 7.8A, V <sub>GS</sub> = 0V ③                      |
|                 |                                        | Q2 | —    | —    | 1.0  |       |                                                                                           |
| t <sub>rr</sub> | Reverse Recovery Time                  | Q1 | —    | 7.8  | 12   | ns    | Q1 T <sub>J</sub> = 25°C, I <sub>F</sub> = 5.1A, V <sub>DD</sub> = 15V, di/dt = 100A/μs ③ |
|                 |                                        | Q2 | —    | 12   | 18   |       |                                                                                           |
| Q <sub>rr</sub> | Reverse Recovery Charge                | Q1 | —    | 1.5  | 2.3  | nC    | Q2 T <sub>J</sub> = 25°C, I <sub>F</sub> = 7.8A, V <sub>DD</sub> = 15V, di/dt = 100A/μs ③ |
|                 |                                        | Q2 | —    | 3.1  | 4.7  |       |                                                                                           |



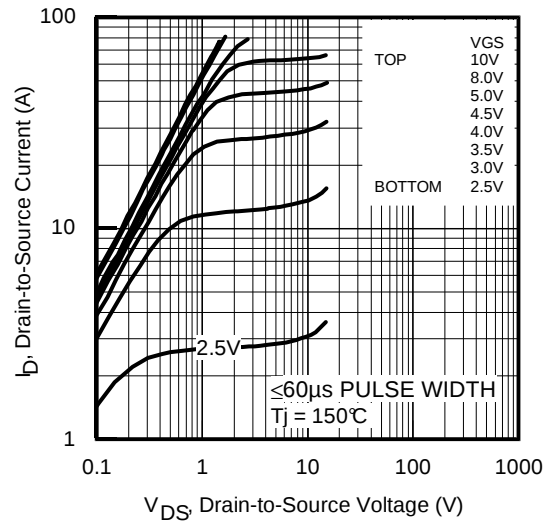
**Fig 1.** Typical Output Characteristics



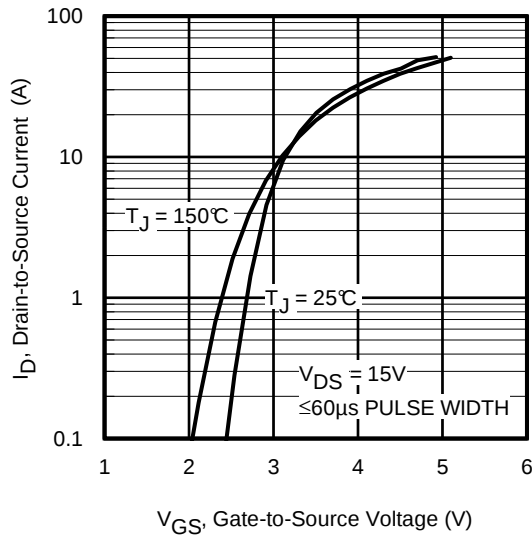
**Fig 2.** Typical Output Characteristics



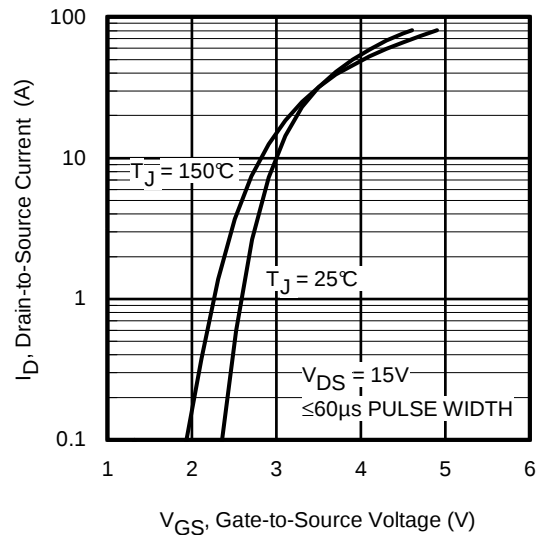
**Fig 3.** Typical Output Characteristics



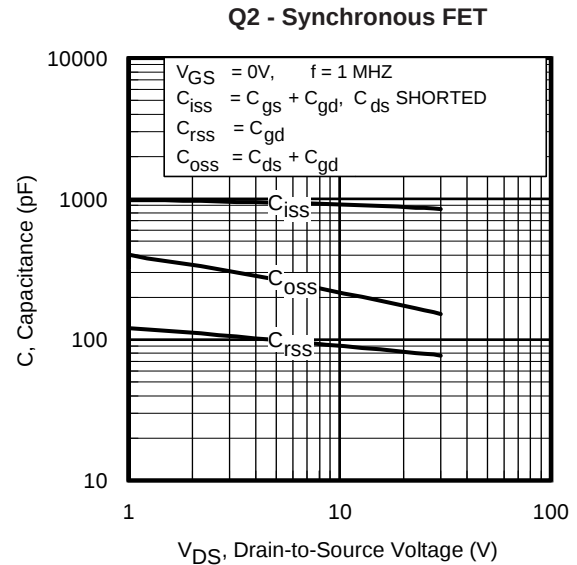
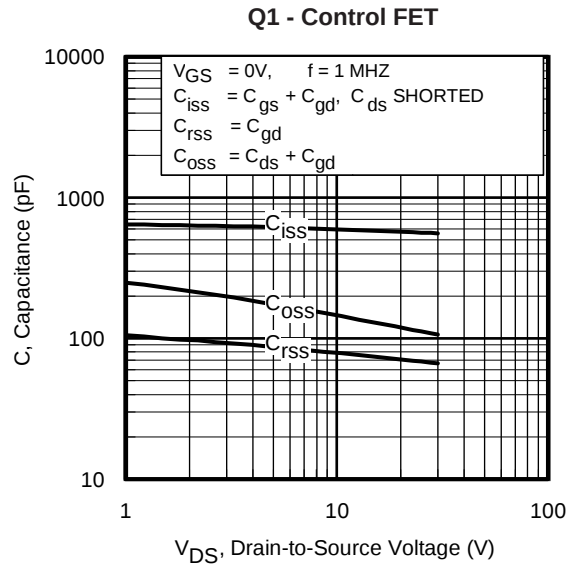
**Fig 4.** Typical Output Characteristics



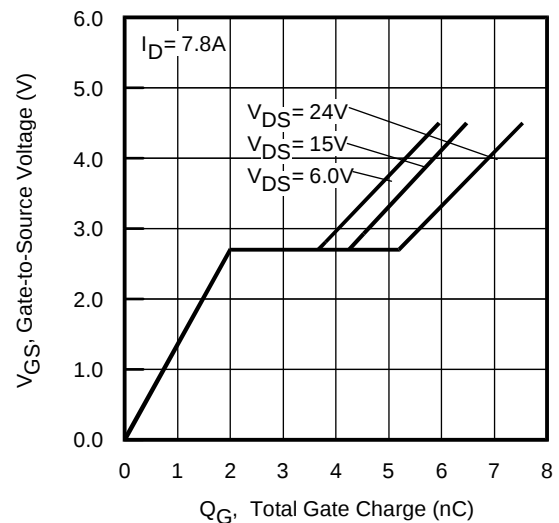
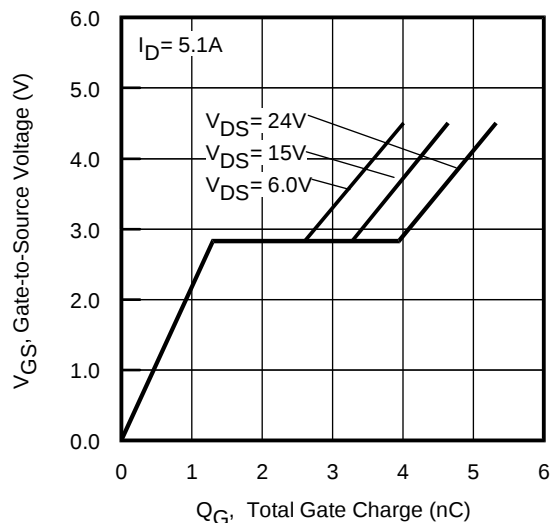
**Fig 5.** Typical Transfer Characteristics



**Fig 6.** Typical Transfer Characteristics

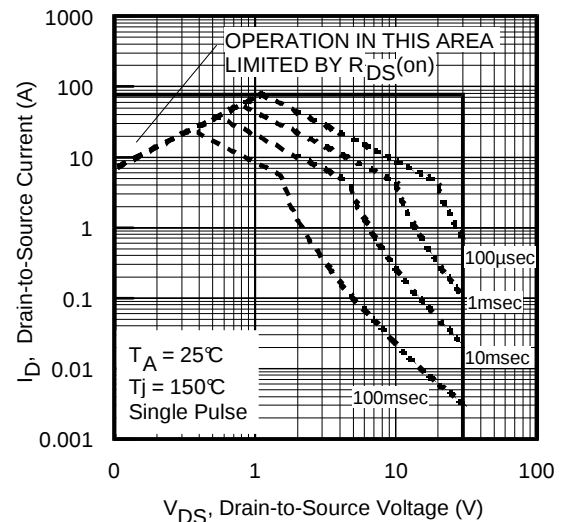
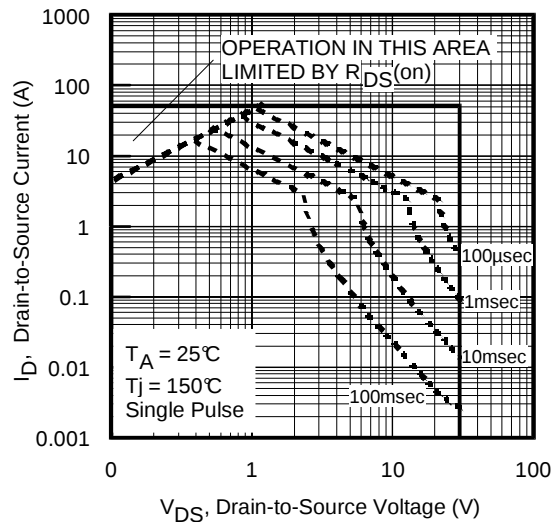


**Fig 7.** Typical Capacitance vs. Drain-to-Source Voltage **Fig 8.** Typical Capacitance vs. Drain-to-Source Voltage



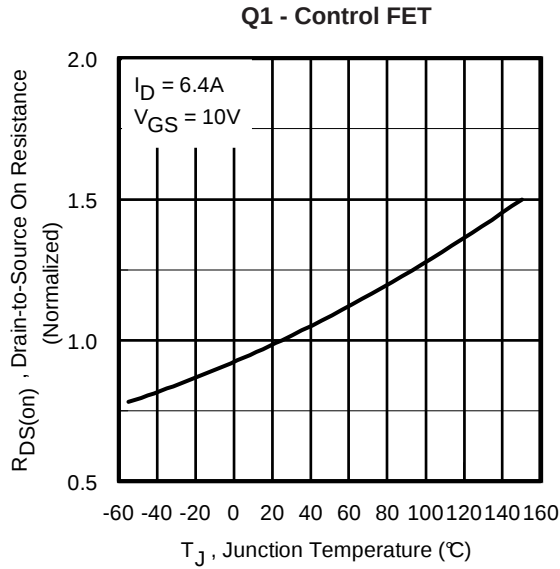
**Fig 9.** Typical Gate Charge vs. Gate-to-Source Voltage

**Fig 10.** Typical Gate Charge vs. Gate-to-Source Voltage

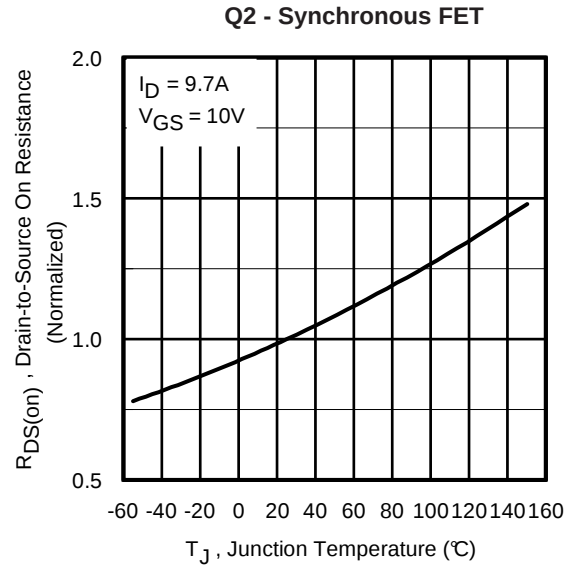


**Fig 11.** Maximum Safe Operating Area

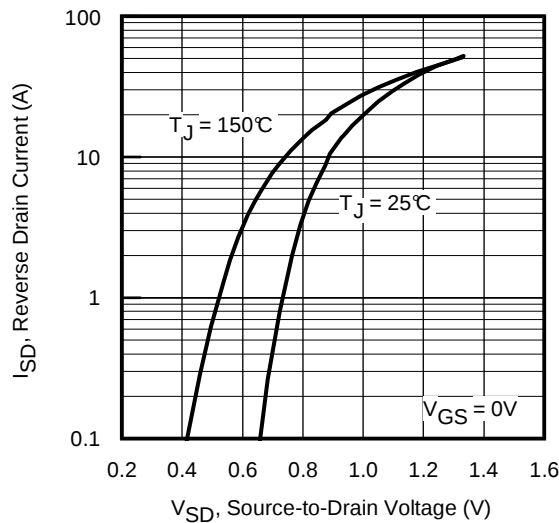
**Fig 12.** Maximum Safe Operating Area



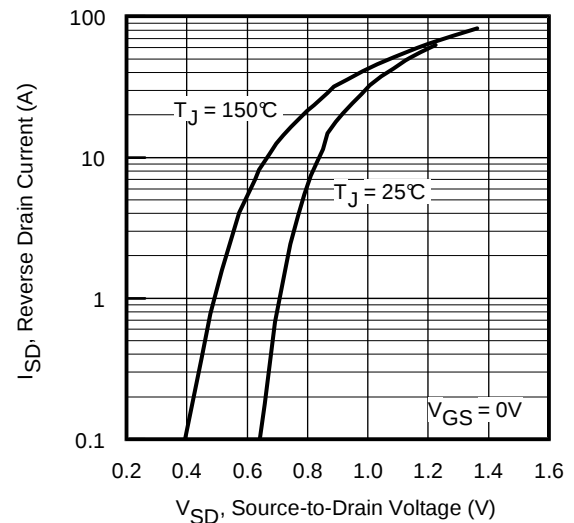
**Fig 13.** Normalized On-Resistance vs. Temperature



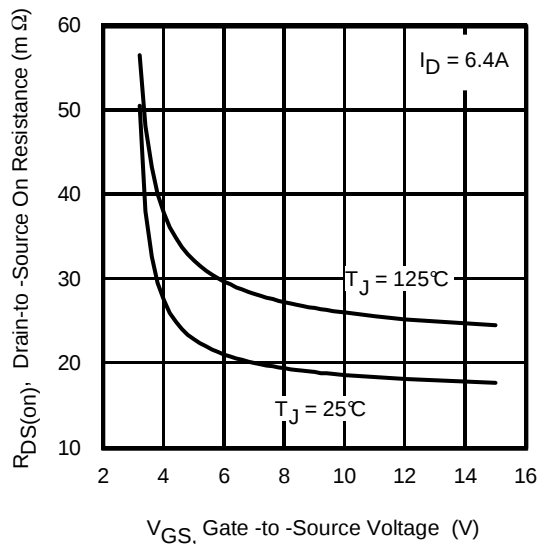
**Fig 14.** Normalized On-Resistance vs. Temperature



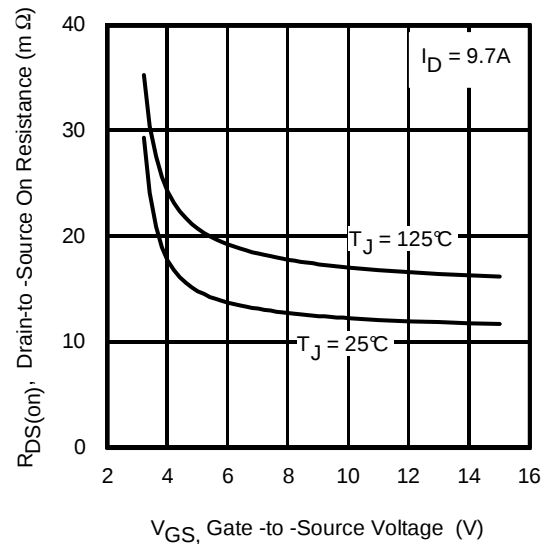
**Fig 15.** Typical Source-Drain Diode Forward Voltage



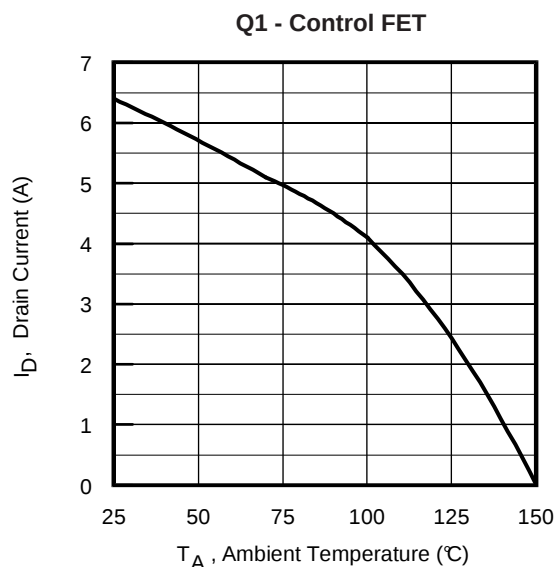
**Fig 16.** Typical Source-Drain Diode Forward Voltage



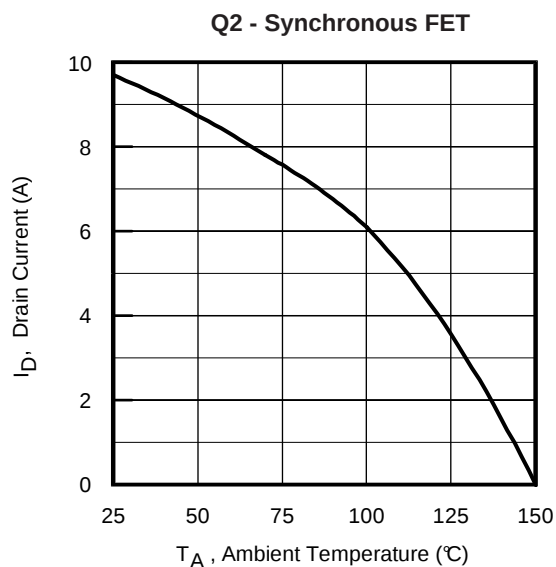
**Fig 17.** Typical On-Resistance vs. Gate Voltage



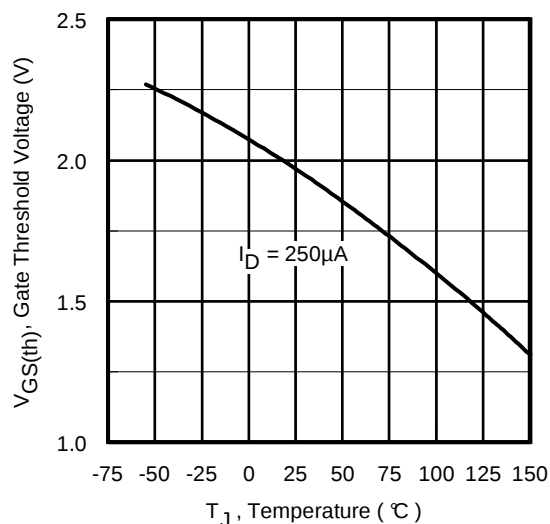
**Fig 18.** Typical On-Resistance vs. Gate Voltage



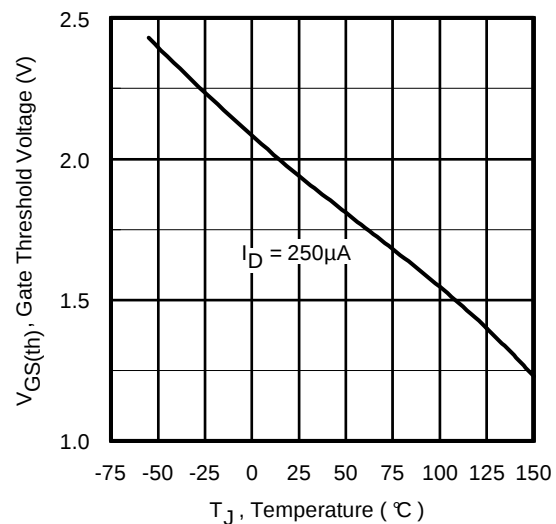
**Fig 19.** Maximum Drain Current vs. Ambient Temperature



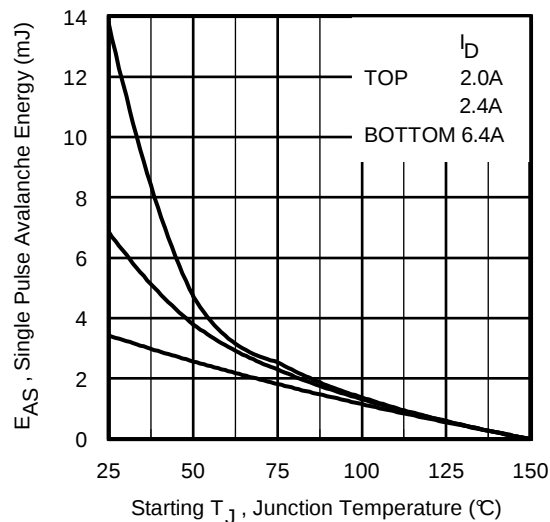
**Fig 20.** Maximum Drain Current vs. Ambient Temperature



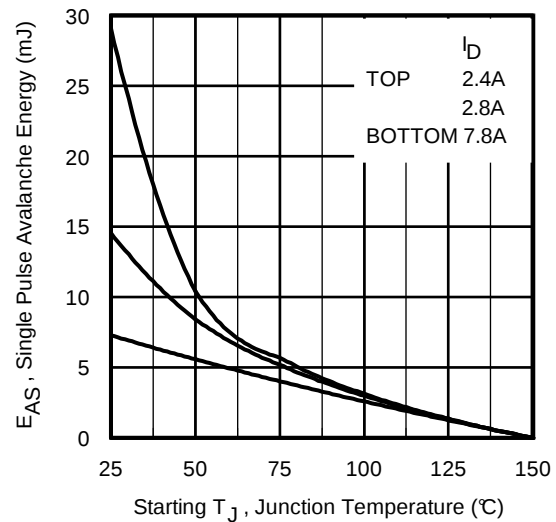
**Fig 21.** Threshold Voltage vs. Temperature



**Fig 22.** Threshold Voltage vs. Temperature



**Fig 23.** Maximum Avalanche Energy vs. Drain Current



**Fig 24.** Maximum Avalanche Energy vs. Drain Current

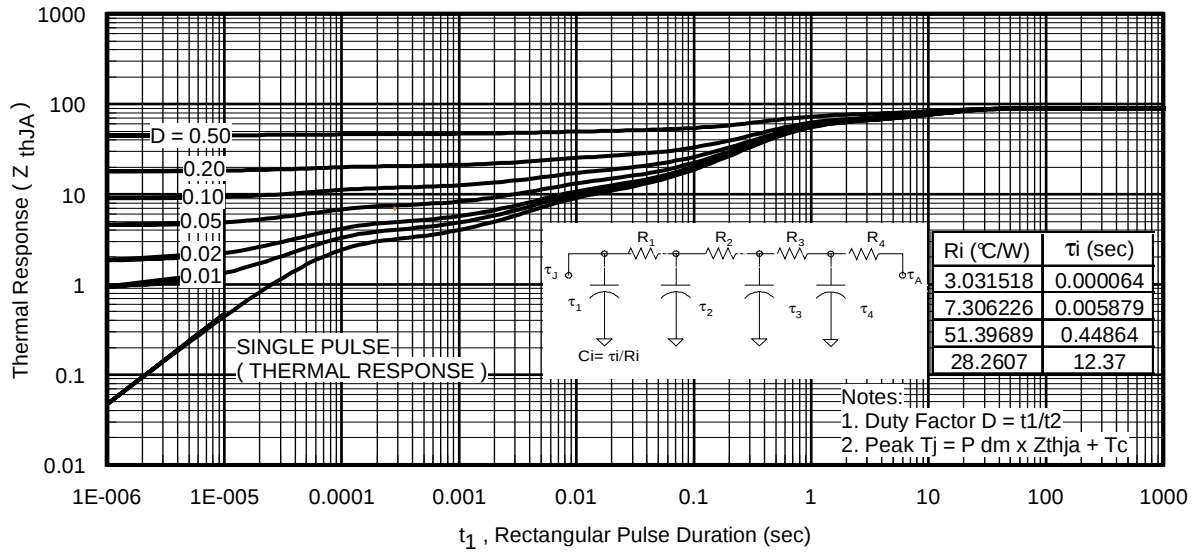


Fig 25. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient (Q1)

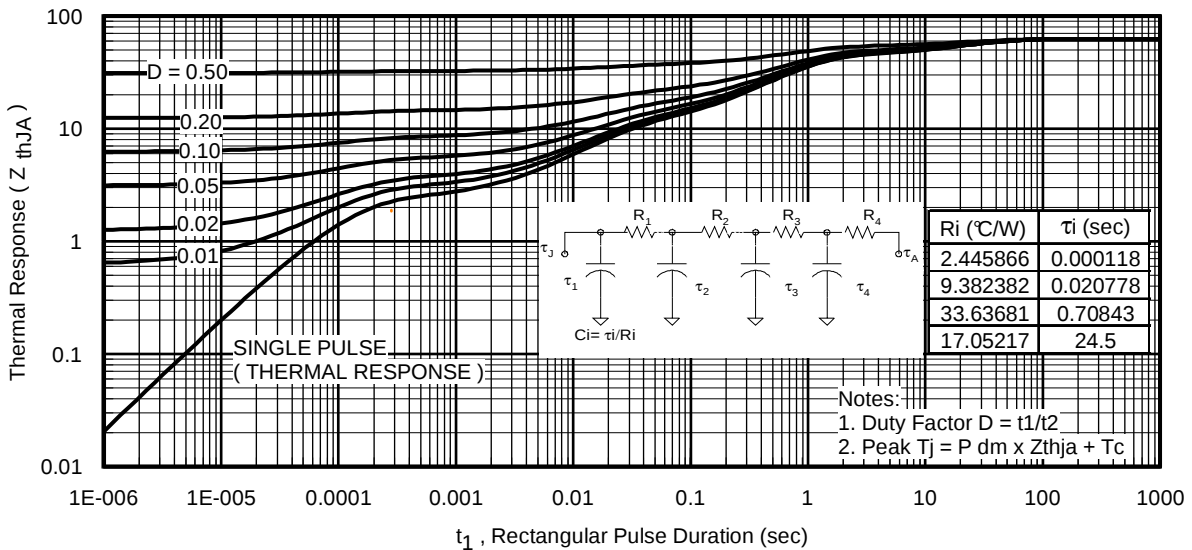


Fig 26. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient (Q2)

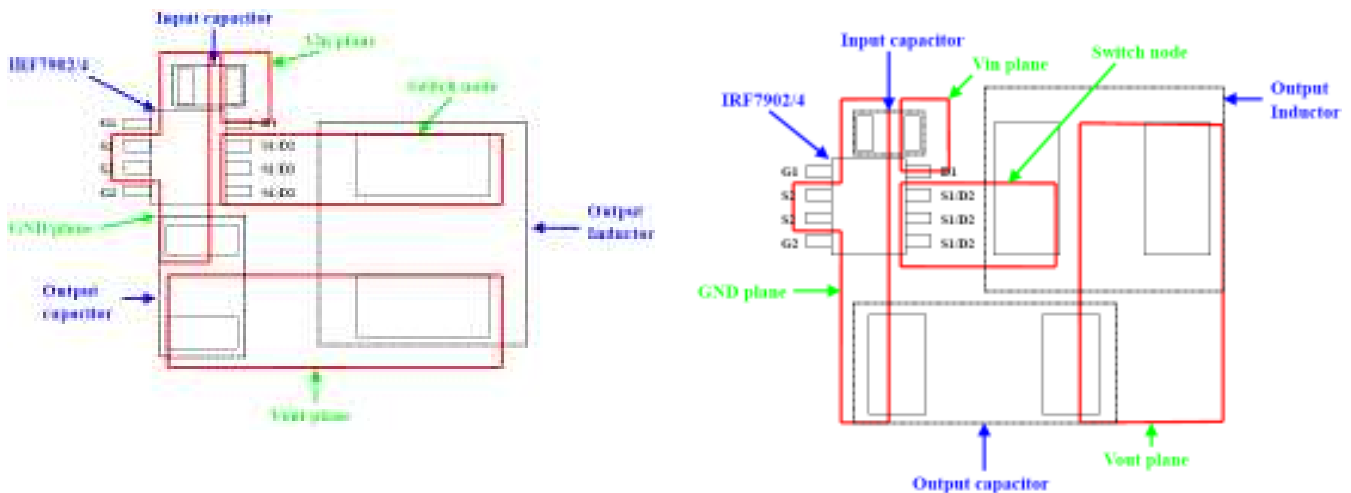
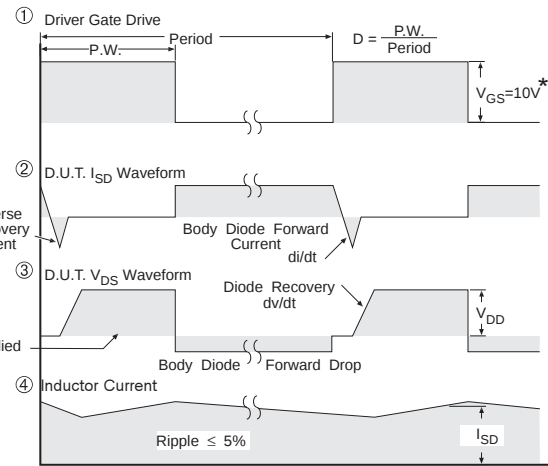
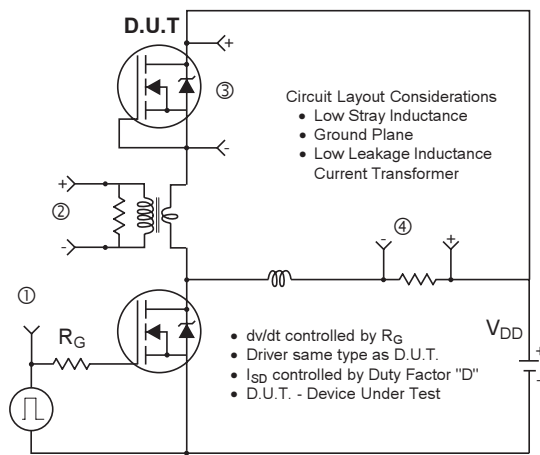
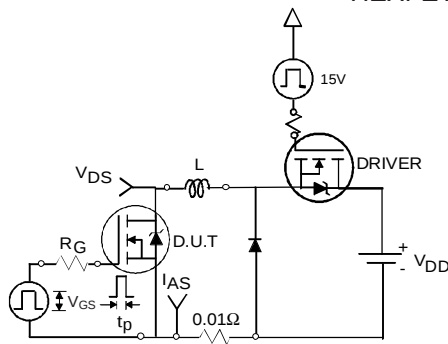


Fig 27. Layout Diagram

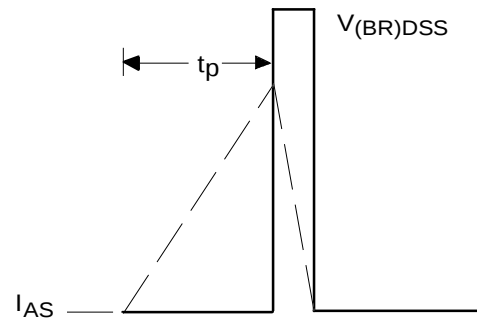


\*  $V_{GS} = 5V$  for Logic Level Devices

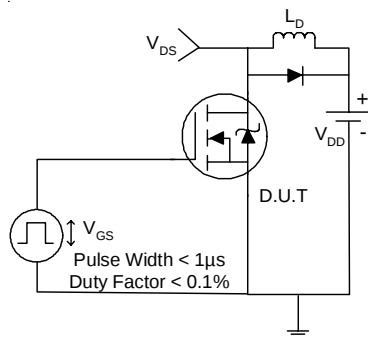
**Fig 28. Peak Diode Recovery  $dv/dt$  Test Circuit for N-Channel HEXFET® Power MOSFETs**



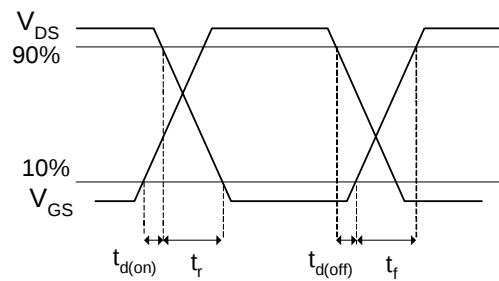
**Fig 29a. Unclamped Inductive Test Circuit**



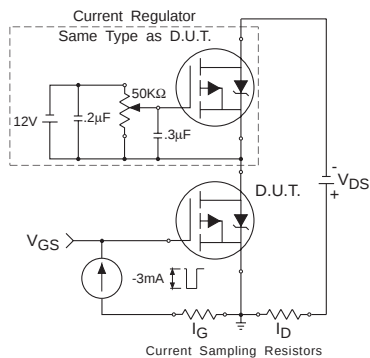
**Fig 29b. Unclamped Inductive Waveforms**



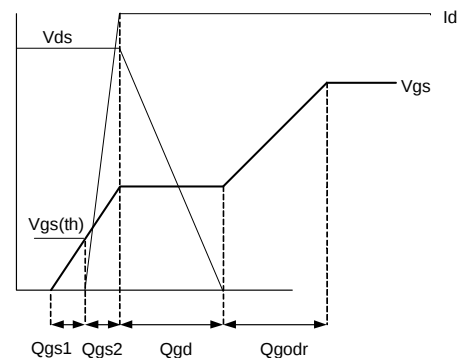
**Fig 30a. Switching Time Test Circuit**



**Fig 30b. Switching Time Waveforms**



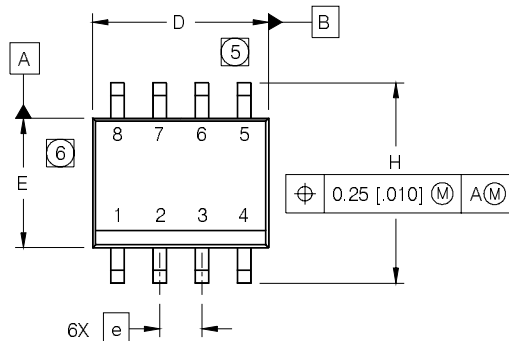
**Fig 31a. Gate Charge Test Circuit**



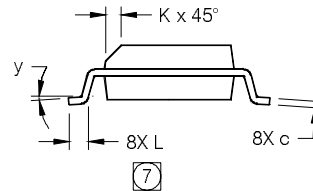
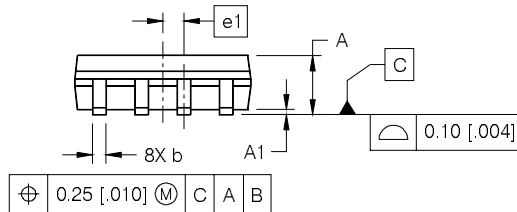
**Fig 31b. Gate Charge Waveform**

## SO-8 Package Outline

Dimensions are shown in millimeters (inches)



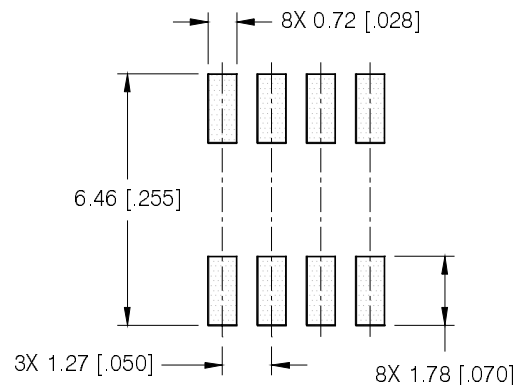
| DIM | INCHES     |       | MILLIMETERS |      |
|-----|------------|-------|-------------|------|
|     | MIN        | MAX   | MIN         | MAX  |
| A   | .0532      | .0688 | 1.35        | 1.75 |
| A1  | .0040      | .0098 | 0.10        | 0.25 |
| b   | .013       | .020  | 0.33        | 0.51 |
| c   | .0075      | .0098 | 0.19        | 0.25 |
| D   | .189       | .1968 | 4.80        | 5.00 |
| E   | .1497      | .1574 | 3.80        | 4.00 |
| e   | .050 BASIC |       | 1.27 BASIC  |      |
| e 1 | .025 BASIC |       | 0.635 BASIC |      |
| H   | .2284      | .2440 | 5.80        | 6.20 |
| K   | .0099      | .0196 | 0.25        | 0.50 |
| L   | .016       | .050  | 0.40        | 1.27 |
| y   | 0°         | 8°    | 0°          | 8°   |



### NOTES:

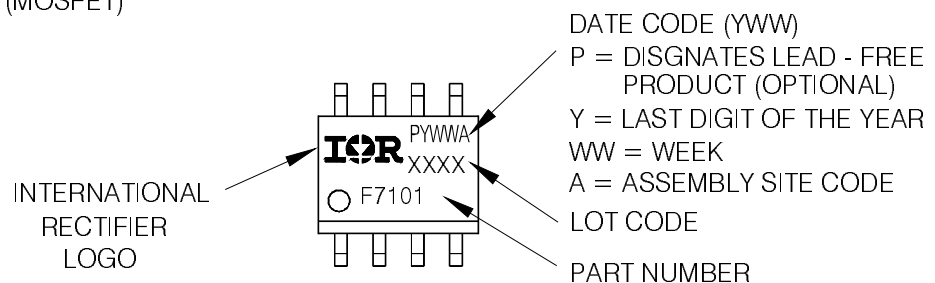
1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: MILLIMETER
3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.
5. DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.15 [.006].
6. DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.25 [.010].
7. DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE.

### FOOTPRINT



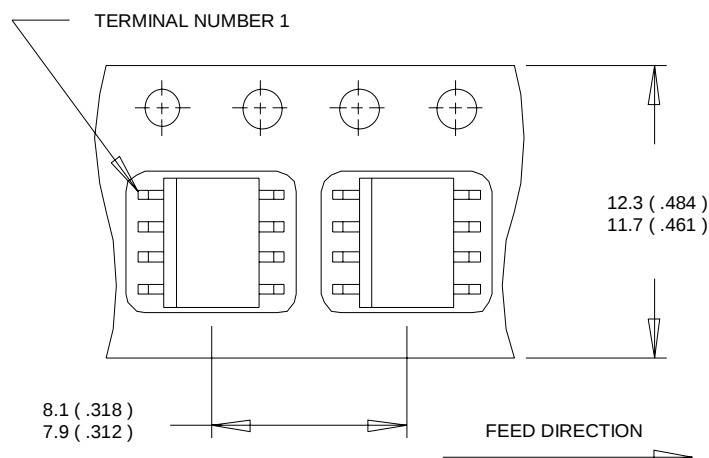
## SO-8 Part Marking Information

EXAMPLE: THIS IS AN IRF7101 (MOSFET)



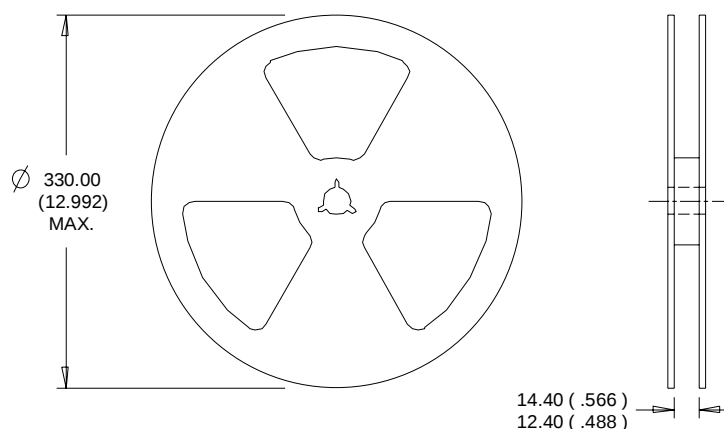
## SO-8 Tape and Reel

Dimensions are shown in millimeters (inches)



### NOTES:

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



### NOTES :

1. CONTROLLING DIMENSION : MILLIMETER.
2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting  $T_J = 25^\circ\text{C}$ , Q1:  $L = 0.26\text{mH}$ ,  $R_G = 25\Omega$ ,  $I_{AS} = 5.1\text{A}$ ;  
Q2:  $L = 0.24\text{mH}$ ,  $R_G = 25\Omega$ ,  $I_{AS} = 7.8\text{A}$ .
- ③ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

- ④ When mounted on 1 inch square copper board.
- ⑤  $R_\theta$  is measured at  $T_J$  approximately  $90^\circ\text{C}$ .

Data and specifications subject to change without notice.  
This product has been designed and qualified for the Consumer market.  
Qualification Standards can be found on IR's Web site.

International  
**IR** Rectifier

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